



12V P-CHANNEL ENHANCEMENT MODE MOSFET

Product Summary

BV _{DSS}	R _{DS(ON)} max	I _D max T _A = +25°C
-12V	$11m\Omega @ V_{GS} = -4.5V$	-11A
	14mΩ @ V _{GS} = -3.7V	-9.7A
	19mΩ @ V _{GS} = -2.5V	-8.3A
	30mΩ @ V _{GS} = -1.8V	-6.6A

Description

This new generation MOSFET is designed to minimize the on-state resistance (R_{DS(ON)}) and yet maintain superior switching performance, making it ideal for high efficiency power management applications.

Applications

- Battery Management Application
- Power Management Functions
- DC-DC Converters

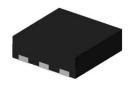
Features

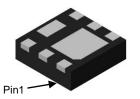
- 0.6mm Profile Ideal for Low Profile Applications
- PCB Footprint of 4mm²
- Low On-Resistance
- · Fast Switching Speed
- Totally Lead-Free & Fully RoHS Compliant (Notes 1 & 2)
- Halogen and Antimony Free. "Green" Device (Note 3)

Mechanical Data

- Case: U-DFN2020-6 (Type F)
- Case Material: Molded Plastic, "Green" Molding Compound.
 UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper Leadframe. Solderable per MIL-STD-202, Method 208 (4)
- Weight: 0.007 grams (Approximate)

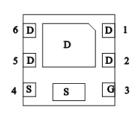
U-DFN2020-6 (Type F)



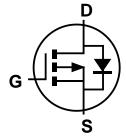


Top View

Bottom View



Pin Out Bottom View



Internal Schematic

Ordering Information (Note 4)

Part Number	Case	Packaging
DMP1009UFDF-7	U-DFN2020-6 (Type F)	3,000/Tape & Reel
DMP1009UFDF-13	U-DFN2020-6 (Type F)	10,000/Tape & Reel

Notes: 1. No purposely added lead. Fully EU Directive 2002/95/EC (RoHS), 2011/65/EU (RoHS 2) & 2015/863/EU (RoHS 3) compliant.

- 2. See https://www.diodes.com/quality/lead-free/ for more information about Diodes Incorporated's definitions of Halogen- and Antimony-free, "Green" and Lead-free
- 3. Halogen- and Antimony-free "Green" products are defined as those which contain <900ppm bromine, <900ppm chlorine (<1500ppm total Br + Cl) and <1000ppm antimony compounds.
- 4. For packaging details, go to our website at https://www.diodes.com/design/support/packaging/diodes-packaging/.

Marking Information



FZ = Product Type Marking Code YM = Date Code Marking Y = Year (ex: F = 2018) M = Month (ex: 9 = September)

Date Code Key

Year	2017		2018	2019		2020	2021		2022	2023	3	2024
Code	Е		F	G		Н			J	K		L
Month	Jan	Feb	Mar	Apr	May	y Jun	Jul	Au	g Sep	Oct	Nov	Dec
Code	1	2	3	4	5	6	7	8	9	0	N	D



Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic	Symbol	Value	Unit		
Drain-Source Voltage	V_{DSS}	-12	V		
Gate-Source Voltage	V_{GSS}	±8	V		
Continuous Drain Compant V 4 5 V (Note C)	Steady State	$T_A = +25^{\circ}C$ $T_A = +70^{\circ}C$	I _D	-11 -8.7	А
Continuous Drain Current V _{GS} = -4.5V (Note 6)	t<5s	$T_A = +25$ °C $T_A = +70$ °C	I _D	-15 -12	А
Pulsed Drain Current (10µs Pulse, Duty Cycle = 1%)	I _{DM}	-70	Α		
Maximum Body Diode Continuous Current (Note 6)	I _S	-2.5	Α		
Avalanche Current (Note 7) L = 0.1mH	I _{AS}	-24	Α		
Avalanche Energy (Note 7) L = 0.1mH	E _{AS}	31	mJ		

Thermal Characteristics

Characteristic		Symbol	Value	Unit
Total Power Dissipation (Note 5)	T _A = +25°C	P_{D}	0.8	W
Thermal Resistance, Junction to Ambient (Note 5)	Steady State		152	°C/W
memiai Resistance, Junction to Ambient (Note 5)	t<5s	$R_{\theta JA}$	81	C/VV
Total Power Dissipation (Note 6)	T _A = +25°C	P_{D}	2.0	W
Thermal Resistance, Junction to Ambient (Note 6)	Steady State		63	
memiai Resistance, Junction to Ambient (Note 6)	t<5s	$R_{\theta JA}$	34	°C/W
Thermal Resistance, Junction to Case (Note 6)	Steady State	$R_{ heta JC}$	15	
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

Electrical Characteristics (@T_A = +25°C, unless otherwise specified.)

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 8)							
Drain-Source Breakdown Voltage	BV _{DSS}	-12	l	_	V	$V_{GS} = 0V, I_D = -250\mu A$	
Zero Gate Voltage Drain Current	I _{DSS}	_	l	-100	nA	$V_{DS} = -9.6V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_		±100	nA	$V_{GS} = \pm 8V$, $V_{DS} = 0V$	
ON CHARACTERISTICS (Note 8)							
Gate Threshold Voltage	V _{GS(TH)}	-0.3	-	-1.0	V	$V_{DS} = V_{GS}, I_{D} = -250 \mu A$	
			8.3	11		$V_{GS} = -4.5V, I_{D} = -5A$	
Static Drain-Source On-Resistance	D		9	14	mΩ	$V_{GS} = -3.7V$, $I_{D} = -5A$	
Static Diani-Source On-Resistance	R _{DS(ON)}		12	19	1115.2	$V_{GS} = -2.5V, I_D = -4A$	
			16	30		$V_{GS} = -1.8V, I_{D} = -1A$	
Diode Forward Voltage	V_{SD}	_	-0.8	-1.2	V	$V_{GS} = 0V, I_{S} = -10A$	
DYNAMIC CHARACTERISTICS (Note 9)							
Input Capacitance	C _{iss}	_	1860	_		10)/)/ 0)/	
Output Capacitance	Coss	_	498	_	pF	$V_{DS} = -10V, V_{GS} = 0V,$ f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	_	416	_		I = 1.0WII IZ	
Gate Resistance	R_g	_	11	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = -4.5V)	Qg	_	26	_			
Total Gate Charge (V _{GS} = -8V)	Q_g	_	44	_	nC	V CV I 40A	
Gate-Source Charge	Q_{gs}	_	3.3	_	IIC	$V_{DS} = -6V, I_{D} = -10A$	
Gate-Drain Charge	Q_{gd}	_	8.1	_			
Turn-On Delay Time	t _{D(ON)}	_	7.0	_			
Turn-On Rise Time	t _R	_	10.6	_		$V_{DS} = -6V, V_{GS} = -4.5V,$	
Turn-Off Delay Time	t _{D(OFF)}	_	62.2	_	ns	$R_G = 1\Omega$, $I_D = -8A$	
Turn-Off Fall Time	t _F	_	61	_			
Reverse Recovery Time	t _{RR}	_	34.4	_	ns	1 404 11/14 5004/	
Reverse Recovery Charge	Q_{RR}	_	28.1		nC	I _F = -12A, di/dt = 500A/μs	

5. Device mounted on FR-4 substrate PC board, 2oz copper, with minimum recommended pad layout.

6. Device mounted on FR-4 substrate PC board, 2oz copper, with 1inch square copper plate.

7. I_{AS} and E_{AS} ratings are based on low frequency and duty cycles to keep T_J = +25°C.
 8. Short duration pulse test used to minimize self-heating effect.
 9. Guaranteed by design. Not subject to product testing.





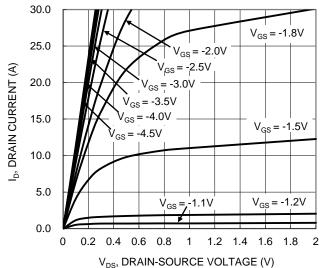


Figure 1. Typical Output Characteristic

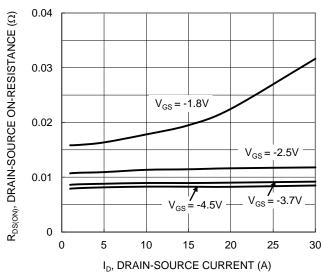


Figure 3. Typical On-Resistance vs. Drain Current and Gate Voltage

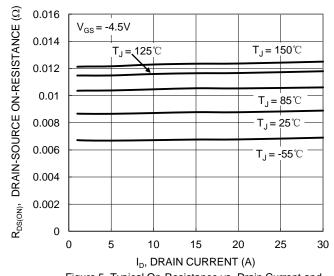


Figure 5. Typical On-Resistance vs. Drain Current and Temperature

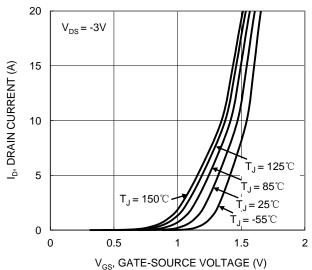


Figure 2. Typical Transfer Characteristic

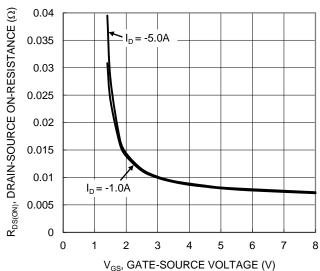


Figure 4. Typical Transfer Characteristic

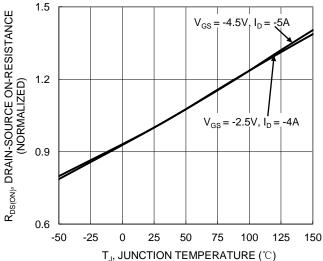


Figure 6. On-Resistance Variation with Temperature



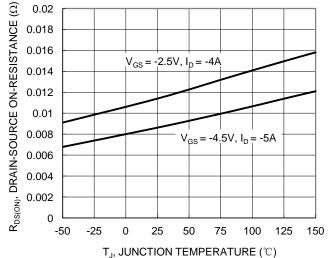
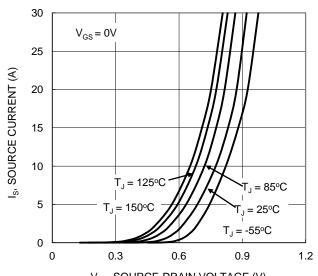
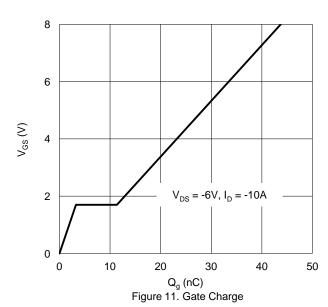


Figure 7. On-Resistance Variation with Temperature

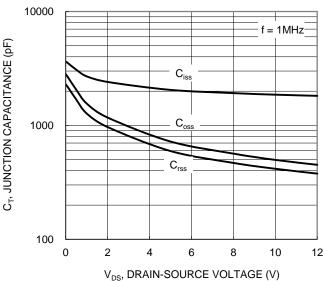


V_{SD}, SOURCE-DRAIN VOLTAGE (V) Figure 9. Diode Forward Voltage vs. Current



 $V_{\text{GS(TH)}},$ GATE THRESHOLD VOLTAGE (V) 8.0 $I_D = -1mA$ 0.6 $I_{D} = -250 \mu A$ 0.4 0.2 0 -50 -25 0 25 50 75 100 125 150 T_J, JUNCTION TEMPERATURE (°C)

Figure 8. Gate Threshold Variation vs. Junciton Temperature



100 R_{DS(ON)} Limited 10 ID, DRAIN CURRENT (A) 1 $P_W = 10 ms$ 0.1 $T_{J(Max)} = 150$ °C $T_C = 25$ °C Single Pulse $P_W = 10s$ DC DUT on 1*MRP Board $V_{GS} = -4.5V$ 0.01 0.01 100 V_{DS}, DRAIN-SOURCE VOLTAGE (V) Figure 12. SOA, Safe Operation Area

Figure 10. Typical Junction Capacitance



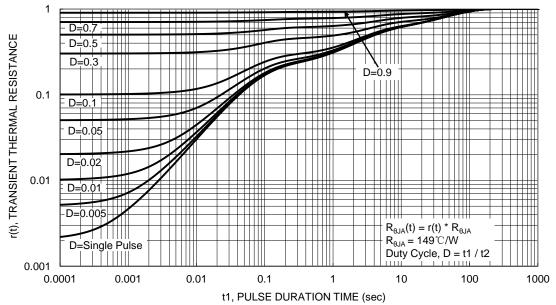


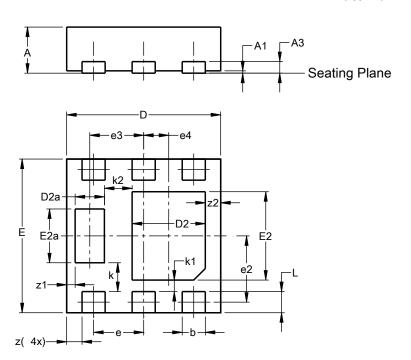
Figure 13. Transient Thermal Resistance



Package Outline Dimensions

Please see http://www.diodes.com/package-outlines.html for the latest version.

U-DFN2020-6 (Type F)

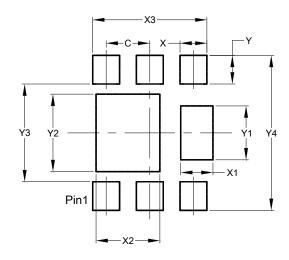


U-DFN2020-6								
(Type F)								
Dim	Min	Max	Тур					
Α	0.57	0.63	0.60					
A1	0.00	0.05	0.03					
A3	-	-	0.15					
b	0.25	0.35	0.30					
D	1.95	2.05	2.00					
D2	0.85	1.05	0.95					
D2a	0.33	0.43	0.38					
E	1.95	2.05	2.00					
E2	1.05	1.25	1.15					
E2a	0.65	0.75	0.70					
е	0.65 BSC							
e2	().863 BS	SC					
е3		0.70 BS	C					
e4	0.325 BSC							
k	0.37 BSC							
k1	0.15 BSC							
k2	0.36 BSC							
L	0.225 0.325 0.275							
Z	0.20 BSC							
z 1	0.110 BSC							
z2	0.20 BSC							
All Dimensions in mm								

Suggested Pad Layout

Please see http://www.diodes.com/package-outlines.html for the latest version.

U-DFN2020-6 (Type F)



Dimensions	Value (in mm)
С	0.650
Х	0.400
X1	0.480
X2	0.950
Х3	1.700
Y	0.425
Y1	0.800
Y2	1.150
Y3	1.450
Y4	2.300



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